

# Search Notes



Application/Control No.

10/041,146

Examiner

Tse Chen

Applicant(s)/Patent under Reexamination

BERTHOUD, CHARLES W.

Art Unit

2116

## SEARCHED

Class	Subclass	Date	Examiner

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
text search only - see "rpt ptlrd"		TSC